

<b>Notice of References Cited</b>	Application/Control No. 10/707,871		Applicant(s)/Patent Under Reexamination LIU ET AL.	
	Examiner ERNEST UNELUS		Art Unit 2181	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0193776	10-2003	Bicknell et al.	361/685
*	B	US-2004/0177218	09-2004	Meehan et al.	711/114
*	C	US-2003/0033477	02-2003	Johnson et al.	711/114
*	D	US-2002/0152355	10-2002	Otterness et al.	711/114
*	E	US-2005/0182887	08-2005	Sakurai et al.	710/315
*	F	US-6,574,709	06-2003	Skazinski et al.	711/119
*	G	US-7,107,320	09-2006	Busser et al.	709/213
*	H	US-2002/0133735	09-2002	McKean et al.	714/5
*	I	US-6,467,034	10-2002	Yanaka, Takeshi	711/162
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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